Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/772,417	YOON ET AL.	
Examiner	Art Unit	
Christopher E. Mahoney	2851	

SEARCHED						
Class	Subclass	Date	Examiner			
359	455-457	5/26/2005	СМ			
	621					
	624					
	,					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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